

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/705,809	CHOU, CHING-HAI	
Examiner	Art Unit	•
Patrick M. Moore	2188	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PLUS Search from EIC (50 Max)	9/28/2005	РММ		
711/205,206 and 714/8,42,710 class search and narrowed with text search to ~200 documents	9/30/2005	РММ		
Text Search for RAID systems and bad sector mapping tables	9/30/2005	РММ		
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